

November 2013

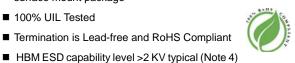
FDMC510P P-Channel PowerTrench[®] MOSFET -20 V, -18 A, 8.0 mΩ

Features

- Max $r_{DS(on)} = 8.0 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -12 \text{ A}$
- Max $r_{DS(on)} = 9.8 \text{ m}\Omega$ at $V_{GS} = -2.5 \text{ V}$, $I_D = -10 \text{ A}$
- Max r_{DS(on)} = 13 mΩ at V_{GS} = -1.8 V, I_D = -9.3 A
- Max $r_{DS(on)}$ = 17 m Ω at V_{GS} = -1.5 V, I_D = -8.3 A

Termination is Lead-free and RoHS Compliant

- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability in a widely used surface mount package
- 100% UIL Tested

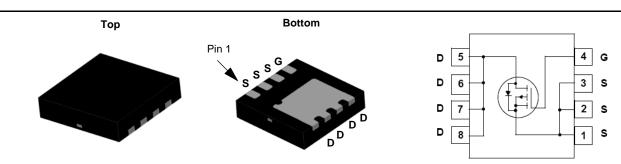


General Description

This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been optimized for r_{DS(ON)}, switching performance and ruggedness.

Applications

- Battery Management
- Load Switch



MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			-20	V	
V _{GS}	Gate to Source Voltage			±8	V	
ID	Drain Current -Continuous (Package limited)	T _C = 25 °C		-18		
	-Continuous (Silicon limited)	-Continuous (Silicon limited) $T_{C} = 25 \text{ °C}$		-54	•	
	-Continuous	T _A = 25 °C	(Note 1a)	-12	A	
	-Pulsed			-50		
E _{AS}	Single Pulse Avalanche Energy			37	mJ	
P _D	Power Dissipation	T _C = 25 °C		41	— w	
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3		
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1	a) 53	0/11

Package Marking and Ordering Information

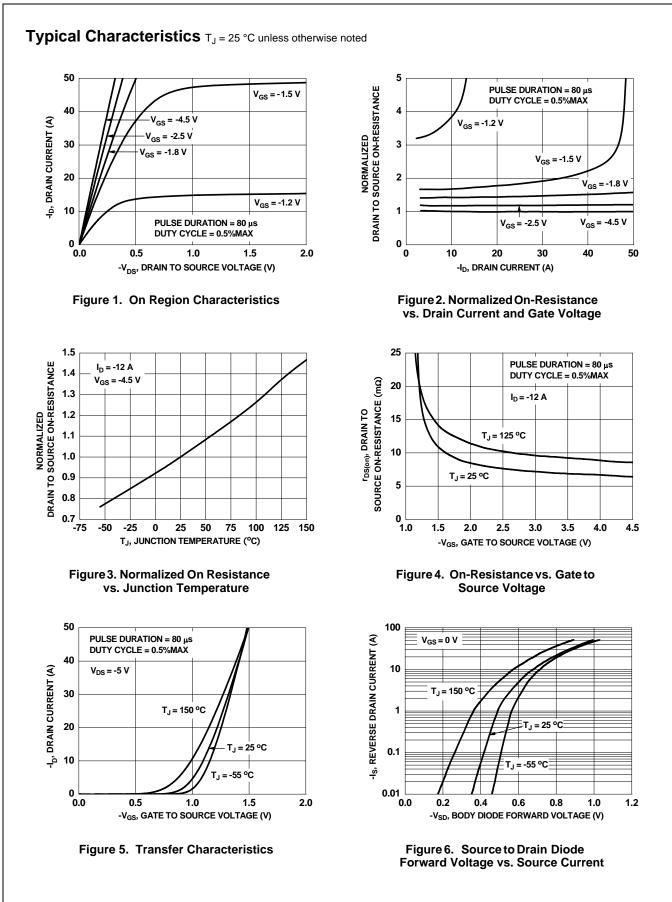
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC510P	FDMC510P	MLP 3.3X3.3	13 "	12 mm	3000 units

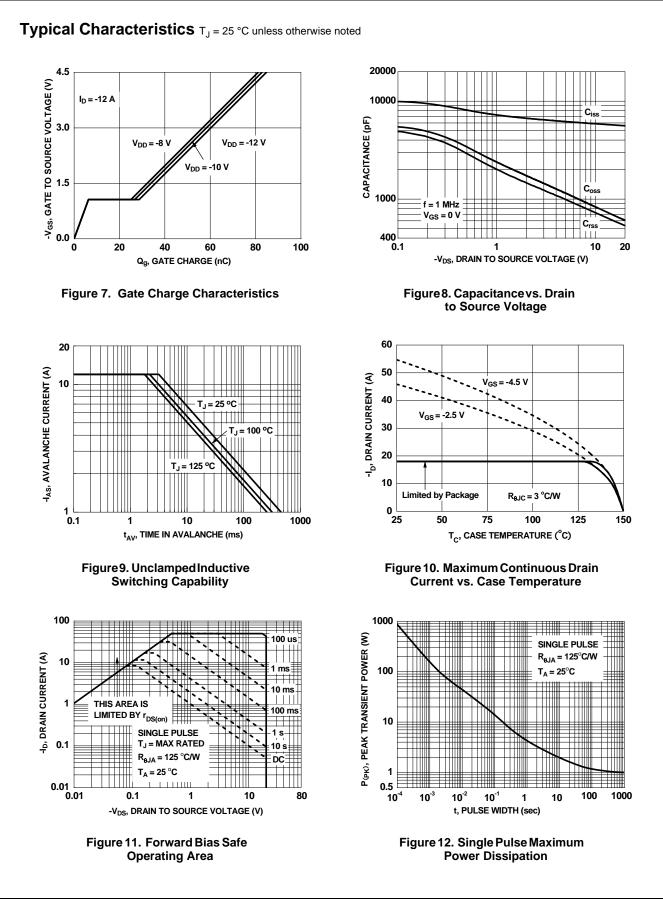
FDMC510P
P-Channel
PowerTrench [®]
MOSFET

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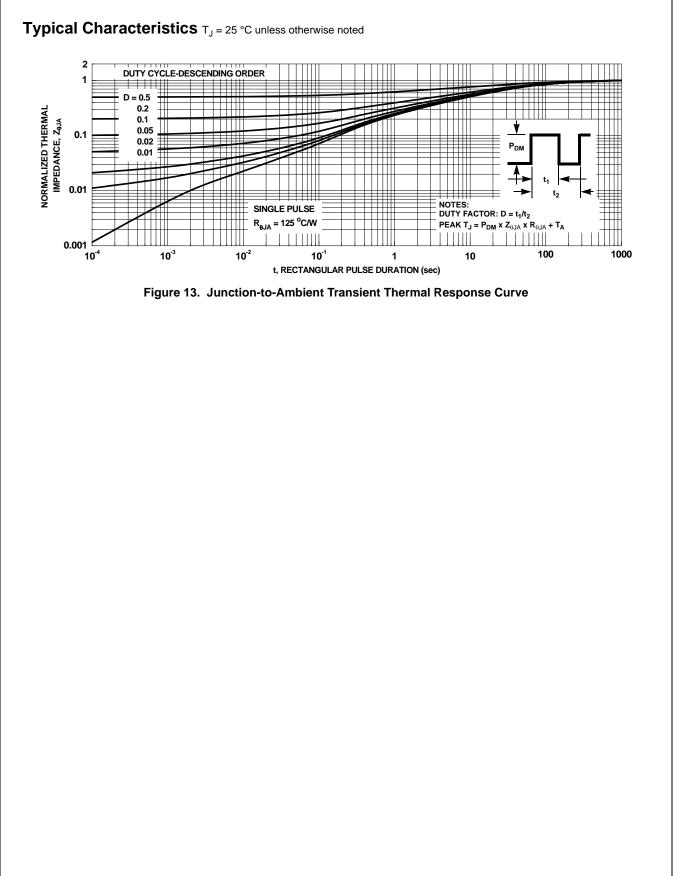
Parameter	Test Conditions	Min	Тур	Max	Units	
cteristics						
Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-20			V	
Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25 °C		-12		mV/°C	
Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V			-1	μA	
Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA	
toristics						
	$V_{00} = V_{00} \ln = -250 \mu A$	-0.4	-0.5	-1.0	V	
		0.4	-0.5	-1.0	-	
Temperature Coefficient	I_D = -250 µA, referenced to 25 °C		3		mV/°C	
	V_{GS} = -4.5 V, I _D = -12 A		6.4	8.0		
	V_{GS} = -2.5 V, I_{D} = -10 A		7.6	9.8		
Static Drain to Source On Resistance	$V_{GS} = -1.8 \text{ V}, I_D = -9.3 \text{ A}$		9.2	13	mΩ	
	$V_{GS} = -1.5 \text{ V}, \text{ I}_{D} = -8.3 \text{ A}$		11	17	1	
	V_{GS} = -4.5 V, I_{D} = -12 A, T_{J} = 125 °C		8.5	12		
Forward Transconductance	V _{DS} = -5 V, I _D = -12 A		75		S	
Characteristics						
			5910	7860	pF	
	V _{DS} = -10 V, V _{GS} = 0 V,				pF	
	f = 1 MHz				pF	
Rise Time Turn-Off Delay Time	V_{DD} = -10 V, I _D = -12 A, V _{GS} = -4.5 V, R _{GEN} = 6 Ω		34 338	55 540	ns ns ns	
					ns	
-	$V_{GS} = 0$ V to -4.5 V				nC	
3	$V_{GS} = 0 \ V \ to \ -2.5 \ V_{DD} = -10 \ V,$			70	nC	
	$I_D = -12 \text{ A}$				nC	
			20.4		nC	
rce Diode Characteristics			0.70	10		
Source to Drain Diode Forward Voltage					V	
Reverse Recovery Time			35	57	ns	
Reverse Recovery Charge	I _F = -12 A, di/dt = 100 A/μs		20	32	nC	
	Zero Gate Voltage Drain Current Gate to Source Leakage Current teristics Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On Resistance Forward Transconductance Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge rce Diode Characteristics Source to Drain Diode Forward Voltage	Zero Gate Voltage Drain Current $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ Gate to Source Leakage Current $V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$ teristicsGate to Source Threshold Voltage $V_{GS} = V_{DS}, I_D = -250 \mu \text{A}$ Gate to Source Threshold Voltage $I_D = -250 \mu \text{A}$, referenced to 25 °CTemperature Coefficient $V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A}$ Static Drain to Source On Resistance $V_{GS} = -1.5 \text{ V}, I_D = -12 \text{ A}$ VGS = -1.5 V, I_D = -10 \text{ A} $V_{GS} = -1.5 \text{ V}, I_D = -3.3 \text{ A}$ VGS = -1.5 V, I_D = -12 \text{ A} $V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A}$ Forward Transconductance $V_{DS} = -5 \text{ V}, I_D = -12 \text{ A}$ CharacteristicsInput Capacitance $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ CharacteristicsTurn-On Delay Time $V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -12 \text{ A}, V_{DD} = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -12 \text{ A}, V_{DD} = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 \text{ A}, V_{DD} = -10 \text{ V}, I_D = -12 $	Zero Gate Voltage Drain Current $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ Gate to Source Leakage Current $V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$ Gate to Source Threshold Voltage $V_{GS} = V_{DS}, I_D = -250 \ \mu\text{A}$ -0.4Gate to Source Threshold Voltage $I_D = -250 \ \mu\text{A}, \text{referenced to 25 °C}$ -0.4Gate to Source Threshold Voltage $I_D = -250 \ \mu\text{A}, \text{referenced to 25 °C}$ -0.4Static Drain to Source On Resistance $V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A}$ -0.4VGS = -1.8 V, I_D = -9.3 A $V_{GS} = -4.5 \text{ V}, I_D = -9.3 \text{ A}$ -0.4VGS = -1.8 V, I_D = -9.3 A $V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A}$ -0.4Vass = -4.5 V, I_D = -12 A, T_J = 125 °CForward Transconductance $V_{DS} = -5 \text{ V}, I_D = -12 \text{ A}$ -0.4CharacteristicsInput Capacitance $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ -0.4CharacteristicsInput Capacitance $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ -0.4CharacteristicsTurn-On Delay Time $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$ -0.4Fail Time $V_{GS} = 0 \text{ V}$ to -4.5 V Total Gate Charge $V_{GS} = 0 \text{ V}$ to -2.5 V Total Gate Charge $V_{GS} = 0 \text{ V}$ to -2.5 V Gate to Drain Twine Forward VoltageV_{CS} = 0 V, I_S = -12 A (Note 2)Ce Diode CharacteristicsSource to Drain Diode Forward VoltageV_{GS} = 0 V, I_S = -2 A (Note 2) <td c<="" td=""><td>Zero Gate Voltage Drain Current$V_{DS} = -16 V$, $V_{GS} = 0 V$Image: constraint of the state interval of the state int</td><td>$\begin{array}{c c c c c c c c c c c c c c c c c c c$</td></td>	<td>Zero Gate Voltage Drain Current$V_{DS} = -16 V$, $V_{GS} = 0 V$Image: constraint of the state interval of the state int</td> <td>$\begin{array}{c c c c c c c c c c c c c c c c c c c$</td>	Zero Gate Voltage Drain Current $V_{DS} = -16 V$, $V_{GS} = 0 V$ Image: constraint of the state interval of the state int	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

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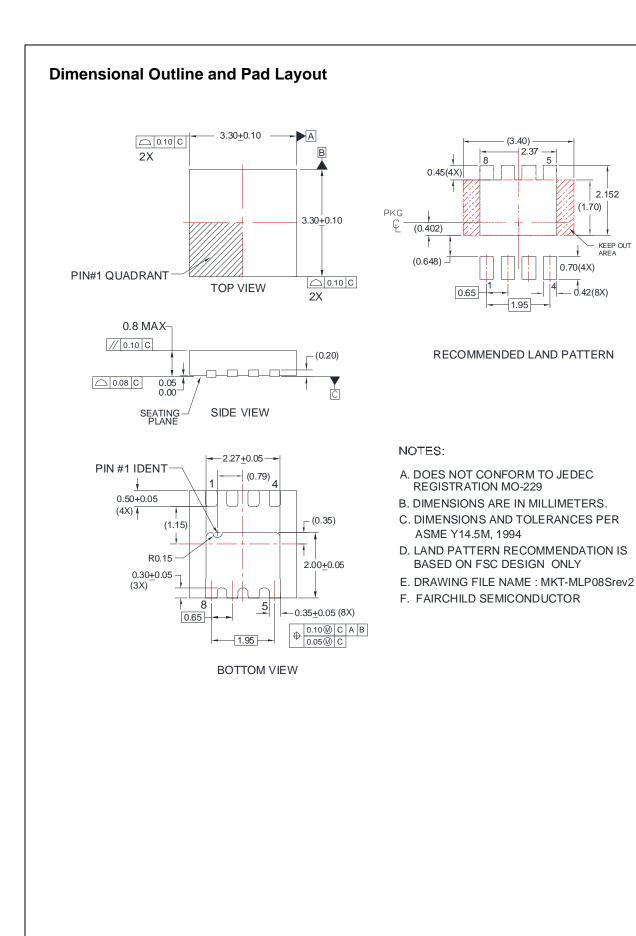


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> KEEP OUT AREA





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